



Features

N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

BV _{SSS}	R _{SS(ON)} Typ	Is Max TA = +25°C
12V	$2.36m\Omega$ @ V _{GS} = $3.8V$	24.4A

Description

This new generation MOSFET is designed to minimize the on-state resistance (Rss(ON)) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Battery Management
- Load Switch
- Battery Protection

Mechanical Data

- Case: X4-DSN3118-6
- Terminal Connections: See Diagram Below

CSP with Footprint 3.05mm × 1.77mm Height = 0.11mm for Low Profile ESD Protection of Gate

- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu. Solderable per MIL-STD-202, Method 208 (24)

Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2) Halogen and Antimony Free. "Green" Device (Note 3)

contact us or your local Diodes representative.

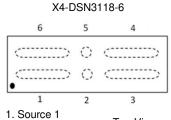
https://www.diodes.com/quality/product-definitions/

For automotive applications requiring specific change control

(i.e. parts qualified to AEC-Q100/101/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please

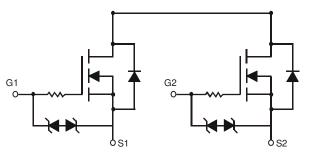
• Weight: 0.0012 grams (Approximate)





- 2. Gate 1 Top
- Source 1
- 4. Source 2
- 5. Gate 2 6. Source 2





Equivalent Circuit

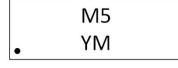
Ordering Information (Note 4)

Ī	Part Number	Case	Packaging
	DMN1002UCA6-7	X4-DSN3118-6	3000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

Marking Information



M5 = Product Type Marking Code YM = Date Code Marking Y or \overline{Y} = Year (ex: G = 2019) M or \overline{M} = Month (ex: 9 = September)

Date Code Key

Year	2017	20	18	2019	2020	20	21	2022	2023	20	24	2025
Code	Е	l l	F	G	Н		l	J	K		_	М
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	-			4	_	_	7	_			N.I.	_



Maximum Ratings (@ $T_A = +25^{\circ}C$, unless otherwise specified.)

Characteristic	Symbol	Value	Unit		
Source-Source Voltage	Vsss	12	V		
Gate-Source Voltage	Vgss	±8	V		
Continuous Source Current (Note 5) V _{GS} = 4.5V	Steady State	$T_A = +25$ °C $T_A = +70$ °C	Is	24.4 19.6	А
Continuous Source Current (Note 5) V _{GS} = 2.5V	Is	16.4 13.1	А		
Pulsed Source Current (Note 6)	Ism	100	Α		

Thermal Characteristics

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 7)	P _D	1.10	W
Thermal Resistance, Junction to Ambient @T _A = +25°C (Note 7)	$R_{\theta JA}$	114.1	°C/W
Power Dissipation (Note 5)	PD	2.47	W
Thermal Resistance, Junction to Ambient @T _A = +25°C (Note 5)	R _{0JA}	50.7	°C/W
Operating and Storage Temperature Range	TJ, TSTG	-55 to +150	°C

Electrical Characteristics (@TA = +25°C, unless otherwise specified.)

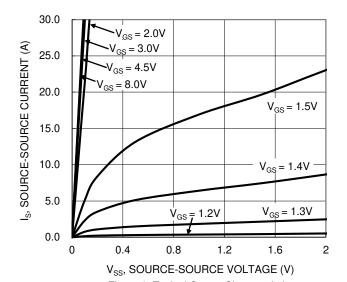
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Source-Source Breakdown Voltage	BVsss	12	_	_	V	$V_{GS} = 0V$, $I_{S} = 1mA$
Zero Gate Voltage Drain Current T _J = +25°C	Isss	_	_	1	μΑ	$V_{SS} = 9.6V$, $V_{GS} = 0V$
Gate-Source Leakage	lass	_		±10	μΑ	$V_{GS} = \pm 8V$, $V_{SS} = 0V$
Gate-Source Leakage	Igss	_	_	±1.0	μΑ	$V_{GS} = \pm 5V$, $V_{SS} = 0V$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V _{GS(TH)}	0.35	0.8	1.4	V	Vss = 10V, $Is = 1.41mA$
		1.5	2.27	2.75		V _G S = 4.5V, I _S = 6A
Ctatic Course Course On Desistance		1.6	2.36	2.85	mΩ	V _{GS} = 3.8V, I _S = 6A
Static Source-Source On-Resistance	Rss(on)	1.7	2.54	3.95		V _{GS} = 3.1V, I _S = 6A
		1.9	2.9	6.1		V _{GS} = 2.5V, I _S = 6A
Diode Forward Voltage	Vss	_	0.69	1.2	V	$V_{GS} = 0V$, $I_{S} = 6A$
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	Ciss	_	3062	4593		101/11/01/
Output Capacitance	Coss	_	758	1137	pF	Vss = 10V, Vgs = 0V, f = 1kHz
Reverse Transfer Capacitance	Crss	_	198	297		I = INIIZ
Total Gate Charge	Qg	_	45.7	68.6		
Gate-Source Charge	Qgs	_	8.3	12.5	nC	Vss = 8V, Vgs = 4V,
Gate-Drain Charge	Qgd	_	16.0	24.0	IIC	Is = 6A
Gate Charge at VTH	Qg(th)	_	4.5	6.8		
Turn-On Delay Time	t _{D(ON)}	_	1005	1508		
Turn-On Rise Time	tR	_	2186	3279	200	$V_{SS} = 8V$, $V_{GS} = 4V$,
Turn-Off Delay Time	tD(OFF)	_	2643	3965	ns	Is = 6A
Turn-Off Fall Time	tF	_	4193	6290		

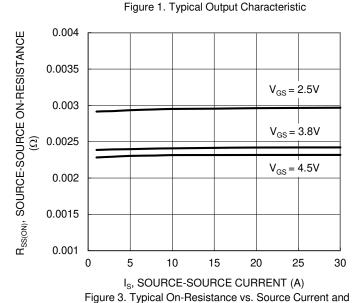
Notes:

- Device mounted on FR-4 material with 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu.
 Repetitive rating, pulse width limited by junction temperature.
 Device mounted on FR-4 PCB with minimum recommended pad layout, single sided.

- 8. Short duration pulse test used to minimize self-heating effect. 9. Guaranteed by design. Not subject to production testing.







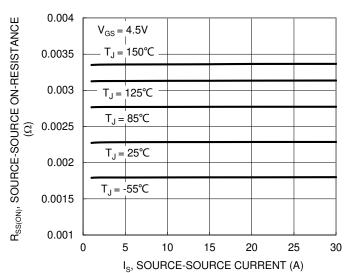
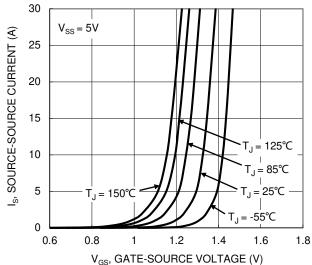


Figure 5. Typical On-Resistance vs. Source Current and Junction Temperature

Gate Voltage



V_{GS}, GATE-SOURCE VOLTAGE (V) Figure 2. Typical Transfer Characteristic

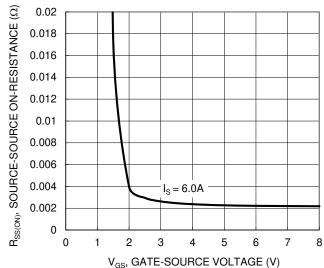


Figure 4. Typical Transfer Characteristic

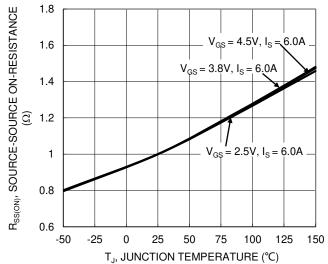


Figure 6. On-Resistance Variation with Junction Temperature



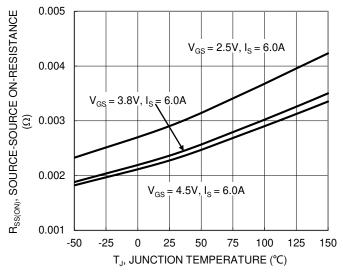
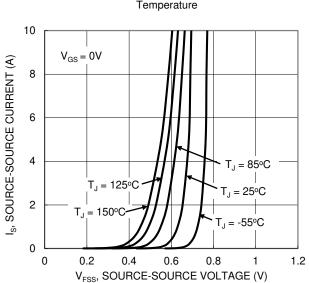
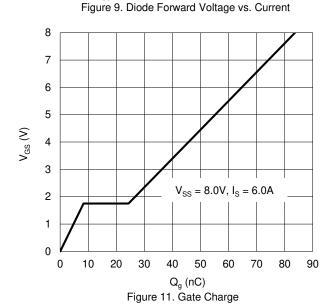


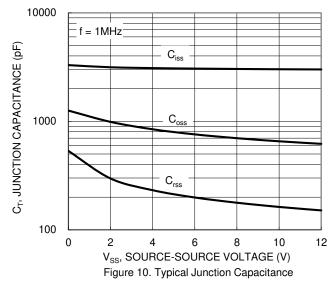
Figure 7. On-Resistance Variation with Junction Temperature





1.2 $V_{\text{GS(TH)}},$ GATE THRESHOLD VOLTAGE (V) $I_S = 1mA$ 8.0 $I_{S} = 250 \mu A$ 0.6 0.4 0.2 -50 -25 0 25 75 100 125 150 50 T_{.i}, JUNCTION TEMPERATURE (°C)

Figure 8. Gate Threshold Variation vs. Junction Temperature



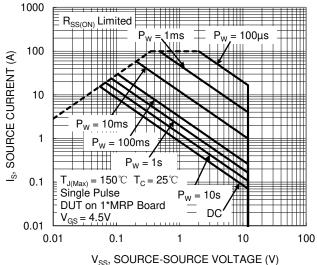


Figure 12. SOA, Safe Operation Area



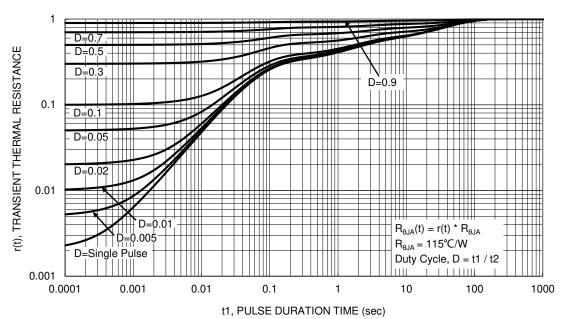


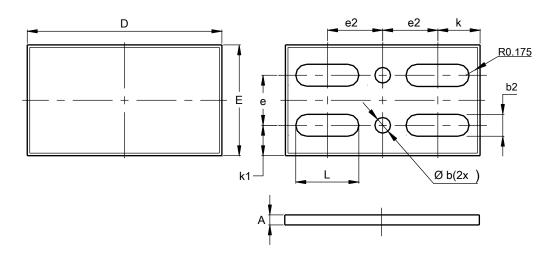
Figure 13. Transient Thermal Resistance



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

X4-DSN3118-6

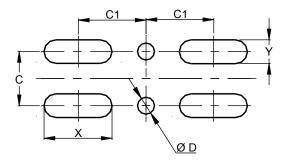


X4-DSN3118-6							
Dim	Min	Max	Тур				
Α	0.09	0.16	0.11				
b	b		0.25				
b2	0.32	0.38	0.35				
D	3.00	3.10	3.05				
Е	1.72	1.82	1.77				
е			0.800				
e2			0.878				
k	-	-	0.648				
k1			0.485				
Ĺ	0.975	1.035	1.005				
All Dimensions in mm							

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

X4-DSN3118-6



Dimensions	/in mm\			
	(in mm)			
С	0.800			
C1	0.878			
D	0.250			
Х	1.005			
Y	0.350			

Value



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